



## P-Channel Enhancement Mode Power MOSFET

## **Description**

The PT I  $\hat{I}$   $\hat{I}$  Huses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

#### **General Features**

•  $V_{DS} = -20V, I_{D} = -9A$ 

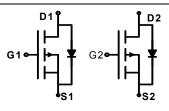
 $R_{DS(ON)}$  < 28m $\Omega$  @  $V_{GS}$ =-4.5V

 $R_{DS(ON)}$  < 40m $\Omega$  @  $V_{GS}$ =-2.5V

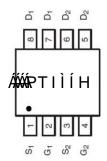
- High power and current handing capability
- Lead free product is acquired
- Surface Mount Package

# **Application**

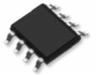
- Motor drive
- Load switch
- Power management



#### Schematic diagram



Marking and pin assignment



SOP-8 top view

#### **Package Marking And Ordering Information**

[	Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
	PTIÌÍH	HÌÍIT¶	SOP-8	Ø330mm	12mm	2500 units

#### Absolute Maximum Ratings (T<sub>A</sub>=25 ℃unless otherwise noted)

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Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V <sub>DS</sub>	-20	V			
Gate-Source Voltage	V <sub>G</sub> s	±12	V			
Drain Current-Continuous	I <sub>D</sub>	-9	Α			
Drain Current-Pulsed (Note 1)	I <sub>DM</sub>	-40	Α			
Maximum Power Dissipation	P <sub>D</sub>	3.1	W			
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$ C			

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	42	°C/W
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## Electrical Characteristics (T<sub>A</sub>=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-20	-	-	V	





Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V	-	-	-1	μA	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V,V <sub>DS</sub> =0V	-	-	±100	nA	
On Characteristics <sup>(Note 3)</sup>							
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-0.5	-0.7	-1.4	V	
Drain-Source On-State Resistance	В	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6A	-	22	28	mΩ	
Diam-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-5A		32	40	mΩ	
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-15V,I <sub>D</sub> =-6A	-	17	-	S	
Dynamic Characteristics (Note4)							
Input Capacitance	C <sub>lss</sub>	\/ - 40\/\/ -0\/	-	2100	-	PF	
Output Capacitance	Coss	- V <sub>DS</sub> =-10V,V <sub>GS</sub> =0V, - F=1.0MHz	-	498	-	PF	
Reverse Transfer Capacitance	C <sub>rss</sub>	F-1.UIVIFIZ	-	300	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t <sub>d(on)</sub>		-	25	-	nS	
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-10V, $R_L$ =10 $\Omega$ ,	-	30	-	nS	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-4.5 $V$ , $R_{GEN}$ =6 $\Omega$	-	70	-	nS	
Turn-Off Fall Time	t <sub>f</sub>		-	50	-	nS	
Total Gate Charge	Qg		-	17	-	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-10V,I <sub>D</sub> =-6A,V <sub>GS</sub> =-4.5V	-	4.1	-	nC	
Gate-Drain Charge	$Q_{gd}$		-	4.3	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-9A	-	-	-1.2	V	

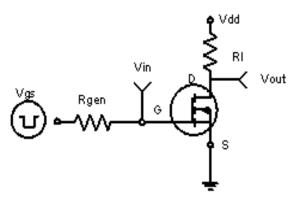
## Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production

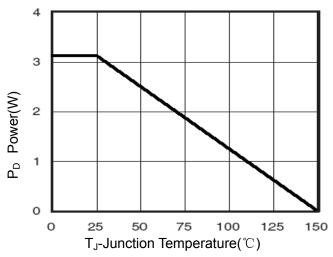




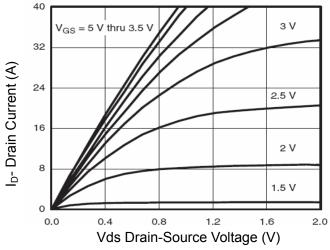
# **Typical Electrical and Thermal Characteristics**



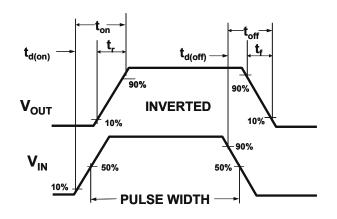
**Figure 1 Switching Test Circuit** 



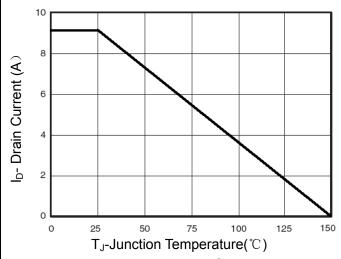
**Figure 3 Power Dissipation** 



**Figure 5 Output Characteristics** 



**Figure 2 Switching Waveforms** 



**Figure 4 Drain Current** 

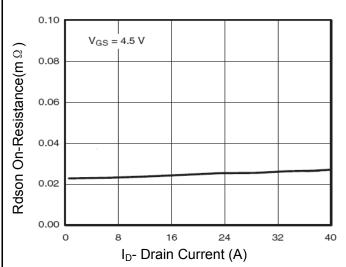
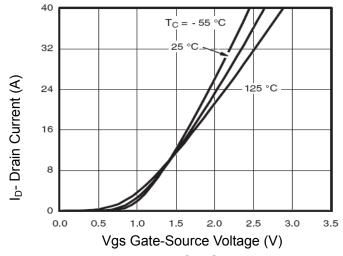


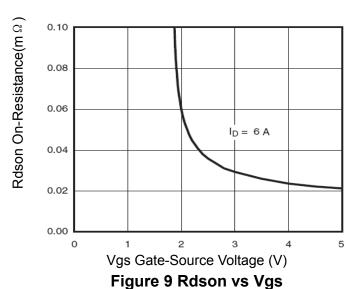
Figure 6 Drain-Source On-Resistance







**Figure 7 Transfer Characteristics** 



V<sub>DS</sub> = 10 V I<sub>D</sub> = 6A

Qg Gate Charge (nC)

Figure 11 Gate Charge

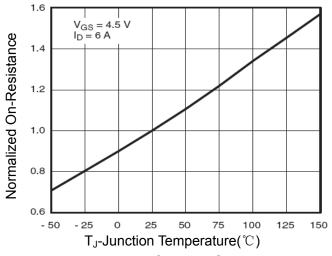


Figure 8 Drain-Source On-Resistance

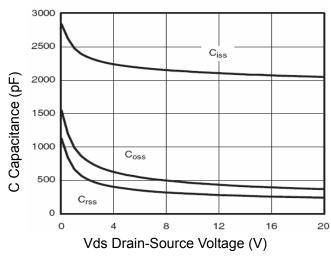


Figure 10 Capacitance vs Vds

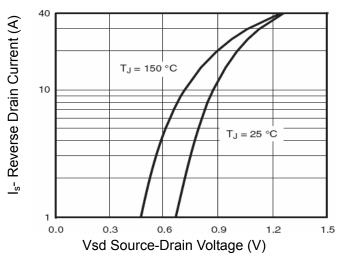


Figure 12 Source- Drain Diode Forward

Vgs Gate-Source Voltage (V)



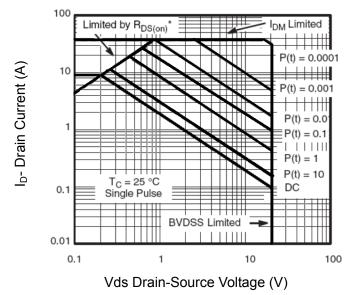
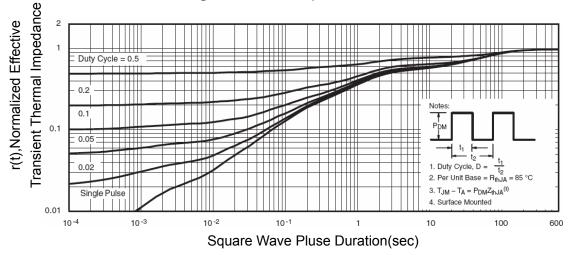


Figure 13 Safe Operation Area

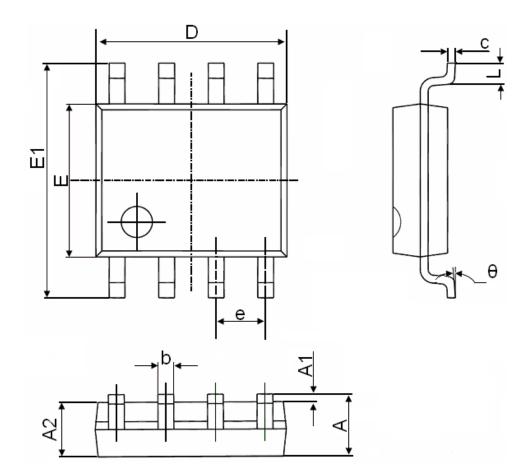


**Figure 14 Normalized Maximum Transient Thermal Impedance** 





# **SOP-8 Package Information**



Cumbal	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
Е	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270	(BSC)	0.050(BSC)		
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	





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